## Notice of References Cited Application/Control No. 10/658,172 Examiner Raymond S. Dean Applicant(s)/Patent Under Reexamination PANPALIYA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0134655	07-2003	Chen et al.	455/522
*	В	US-5,852,782	12-1998	Komatsu, Masahiro	455/522
*	С	US-5,822,682	10-1998	Schroderus et al.	455/63.3
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
7	Ή	US-			
	_	US-			
	, ,	US-			
	К	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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